

Based on Form PTO-1449 (3/90)  LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	ATTY. DOCKET NO.  514413-3843	SERIAL NO.  09/691,915
	APPLICANT  #9 <b>RECEIVED</b> BIERINGER ET AL JUN 12 2002	
	FILING DATE  October 19, 2000	GROUP TECH CENTER 1600/2900 N/A

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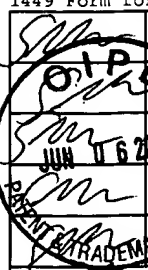

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>SM</i>	AA	US 5,912,207	6/15/1999	Scher et al	504	190	
<i>SM</i>	AB	5,416,061	5/1995	Hewett et al	504	141	

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							YES	NO
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<i>SM</i>	AD	WO 97/22253	6/26/1997	PCT				
<i>SM</i>	AE	FR 2 675 340 (equivalent to US 5,416,061, May 16, 1995, Hewett et al)	10/23/1992	France				
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		/	Patent Abstracts of Japan, JP 05070426, Vol. 017, No. 391, published March 23, 1993
		/	Database WPI, Section CH, Week 199240, also referred to as XP-002171353. <i>Abstract of JP 4230301</i>
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EXAMINER	AN	/	Database WPI, Section CH, Week 199833, also referred to as XP-002171354. <i>Abstract of JP 10-529841.</i>
			DATE CONSIDERED 7/11/2002

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